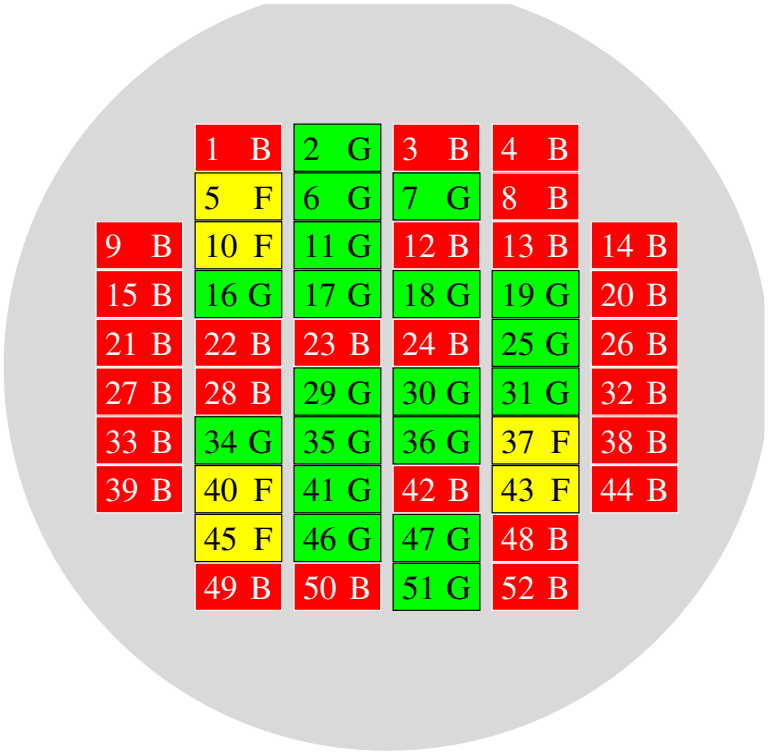
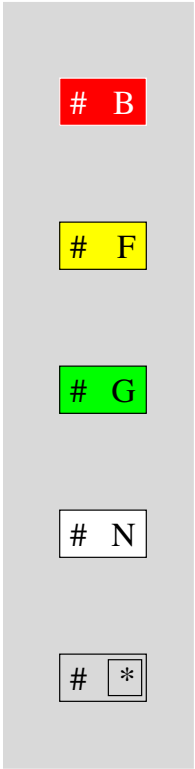
Die quality map for wafer 120 s/n: 21316-04-19

Date: 02/26/99





Bad die

Fair die

Good die

No info

Manually tagged